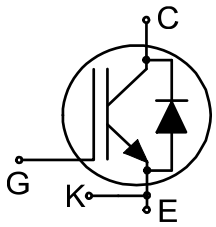
Sixth generation, high speed soft switching series

High speed soft switching TRENCHSTOP™ IGBT 6 in Trench and Fieldstop technology copacked with soft and fast recovery anti-parallel diode

Features:



1200V TRENCHSTOP™ IGBT6 technology offering:
- High efficiency in hard switching and resonant topologies
- Easy paralleling capability due to positive temperature coefficient in V_{CEsat}
- Low EMI
- Low Gate Charge Q_g
- Very soft, fast recovery full current anti-parallel diode
- Maximum junction temperature 175°C
- Pb-free lead plating; RoHS compliant
- Complete product spectrum and PSpice Models: http://www.infineon.com/igbt/

Applications:

- Industrial UPS
- Charger
- Energy storage
- Three-level Solar String Inverter
- Welding

Product Validation:

Qualified for industrial applications according to the relevant tests of JEDEC47/20/22

Key Performance and Package Parameters

Type	V_{CE}	I_C	V_{CEsat}, T_{vj}=25°C	T_{vjmax}	Marking	Package
IKY75N120CS6	1200V	75A	1.85V	175°C	K75MCS6	PG-TO247-4-2

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Sixth generation, high speed soft switching series

Maximum Ratings

For optimum lifetime and reliability, Infineon recommends operating conditions that do not exceed 80% of the maximum ratings stated in this datasheet.

Parameter	Symbol	Value	Unit
Collector-emitter voltage, $T_{vj} \geq 25°C$	V_{CE}	1200	V
DC collector current, limited by T_{vjmax} $T_c = 25°C$ $T_c = 100°C$	I_C	150.0 75.0	A
Pulsed collector current, t_p limited by T_{vjmax}	I_{Cpuls}	300.0	A
Turn off safe operating area $V_{CE} \leq 1200V$, $T_{vj} \leq 175°C$	-	300.0	A
Diode forward current, limited by T_{vjmax} $T_c = 25°C$ $T_c = 100°C$	I_F	150.0 75.0	A
Diode pulsed current, t_p limited by T_{vjmax}	I_{Fpuls}	300.0	A
Gate-emitter voltage Transient Gate-emitter voltage ($t_p \leq 0.5\mu s$, $D < 0.001$)	V_{GE}	±20 25	V
Power dissipation $T_c = 25°C$ Power dissipation $T_c = 100°C$	P_{tot}	880.0 440.0	W
Operating junction temperature	T_{vj}	-40...+175	°C
Storage temperature	T_{stg}	-55...+150	°C
Soldering temperature, wave soldering 1.6mm (0.063in.) from case for 10s		260	°C

Thermal Resistance

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
R_{th} Characteristics						
IGBT thermal resistance, junction - case	$R_{th(j-c)}$		-	-	0.17	K/W
Diode thermal resistance, junction - case	$R_{th(j-c)}$		-	-	0.41	K/W
Thermal resistance junction - ambient	$R_{th(j-a)}$		-	-	40	K/W

Electrical Characteristic, at T_{vj} = 25°C, unless otherwise specified

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Static Characteristic						
Collector-emitter saturation voltage	V_{CEsat}	V_{GE} = 15.0V, I_C = 75.0A T_{vj} = 25°C T_{vj} = 125°C T_{vj} = 175°C	 - - -	 1.85 2.15 2.25	 2.15 - -	V
Diode forward voltage	V_F	V_{GE} = 0V, I_F = 75.0A T_{vj} = 25°C T_{vj} = 175°C	 - -	 2.10 2.15	 2.20 -	V
Gate-emitter threshold voltage	$V_{GE(th)}$	I_C = 3.50mA, V_{CE} = V_{GE}	5.1	5.7	6.3	V
Zero gate voltage collector current	I_{CES}	V_{CE} = 1200V, V_{GE} = 0V T_{vj} = 25°C T_{vj} = 175°C	 - -	 - 3500	 1600 -	µA
Gate-emitter leakage current	I_{GES}	V_{CE} = 0V, V_{GE} = 20V	-	-	600	nA
Transconductance	g_{fs}	V_{CE} = 20V, I_C = 75.0A	-	60.0	-	S

Electrical Characteristic, at T_{vj} = 25°C, unless otherwise specified

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Dynamic Characteristic						
Input capacitance	C_{ies}	V_{CE} = 25V, V_{GE} = 0V, f = 1MHz	-	4900	-	pF
Output capacitance	C_{oes}		-	360	-	
Reverse transfer capacitance	C_{res}		-	225	-	
Gate charge	Q_G	V_{CC} = 960V, I_C = 75.0A, V_{GE} = 15V	-	530.0	-	nC
Internal emitter inductance measured 5mm (0.197 in.) from case	L_E		-	13.0	-	nH

Switching Characteristic, Inductive Load

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
IGBT Characteristic, at T_{vj} = 25°C						
Turn-on delay time	$t_{d(on)}$	T_{vj} = 25°C, V_{CC} = 600V, I_C = 75.0A, V_{GE} = 0.0/15.0V, $R_{G(on)}$ = 4.0Ω, $R_{G(off)}$ = 4.0Ω, $L\sigma$ = 70nH, $C\sigma$ = 67pF $L\sigma$, $C\sigma$ from Fig. E Energy losses include “tail” and diode reverse recovery.	-	32	-	ns
Rise time	t_r		-	32	-	ns
Turn-off delay time	$t_{d(off)}$		-	300	-	ns
Fall time	t_f		-	31	-	ns
Turn-on energy	E_{on}		-	2.20	-	mJ
Turn-off energy	E_{off}		-	2.95	-	mJ
Total switching energy	E_{ts}		-	5.15	-	mJ

Diode Characteristic, at T_{vj} = 25°C

Diode reverse recovery time	t_{rr}	T_{vj} = 25°C, V_R = 600V, I_F = 75.0A, di_F/dt = 2700A/µs, $L\sigma$ = 70nH, $C\sigma$ = 67pF	-	205	-	ns
Diode reverse recovery charge	Q_{rr}		-	4.70	-	µC
Diode peak reverse recovery current	I_{rrm}		-	76.0	-	A
Diode peak rate of fall of reverse recovery current during t_b	di_{rr}/dt		-	-1500	-	A/µs

Switching Characteristic, Inductive Load

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
IGBT Characteristic, at T_{vj} = 175°C						
Turn-on delay time	$t_{d(on)}$	T_{vj} = 175°C, V_{CC} = 600V, I_C = 75.0A, V_{GE} = 0.0/15.0V, $R_{G(on)}$ = 4.0Ω, $R_{G(off)}$ = 4.0Ω, $L\sigma$ = 70nH, $C\sigma$ = 67pF $L\sigma$, $C\sigma$ from Fig. E Energy losses include “tail” and diode reverse recovery.	-	33	-	ns
Rise time	t_r		-	33	-	ns
Turn-off delay time	$t_{d(off)}$		-	370	-	ns
Fall time	t_f		-	58	-	ns
Turn-on energy	E_{on}		-	3.30	-	mJ
Turn-off energy	E_{off}		-	5.30	-	mJ
Total switching energy	E_{ts}		-	8.60	-	mJ

Diode Characteristic, at T_{vj} = 175°C

Diode reverse recovery time	t_{rr}	T_{vj} = 175°C, V_R = 600V, I_F = 75.0A, di_F/dt = 2700A/µs, $L\sigma$ = 70nH, $C\sigma$ = 67pF	-	340	-	ns
Diode reverse recovery charge	Q_{rr}		-	10.60	-	µC
Diode peak reverse recovery current	I_{rrm}		-	105.0	-	A
Diode peak rate of fall of reverse recovery current during t_b	di_{rr}/dt		-	-1050	-	A/µs

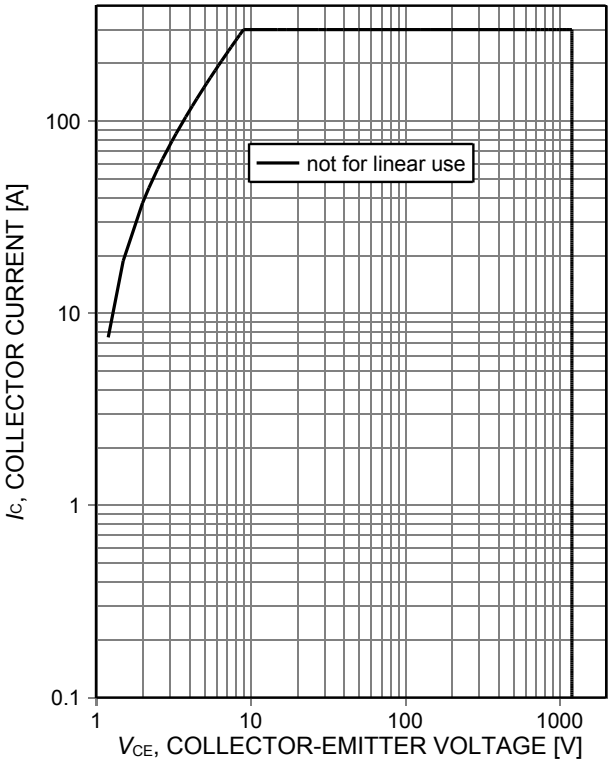

Figure 1. **Forward bias safe operating area** (D=0, T_{vj}≤175°C; V_{GE}=15V, pulse width limited by T_{vjmax})

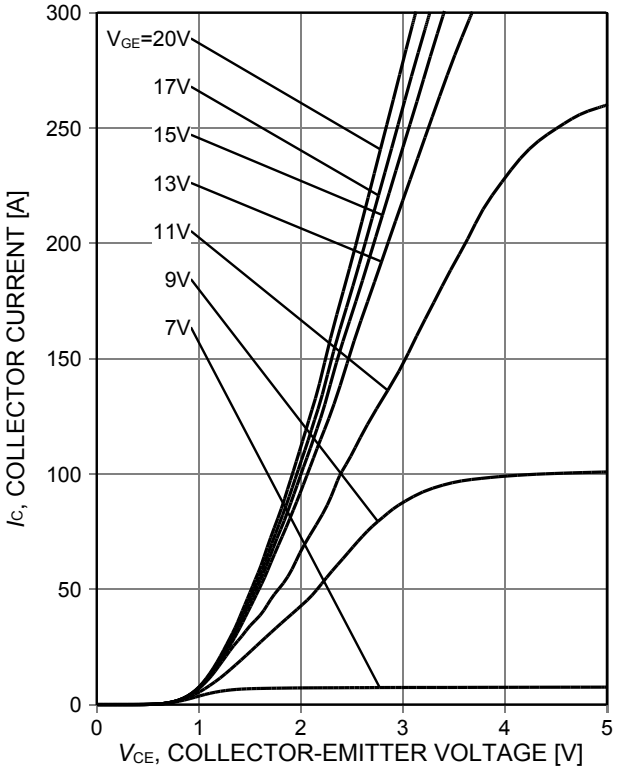

Figure 2. **Typical output characteristic** (T_{vj}=25°C)

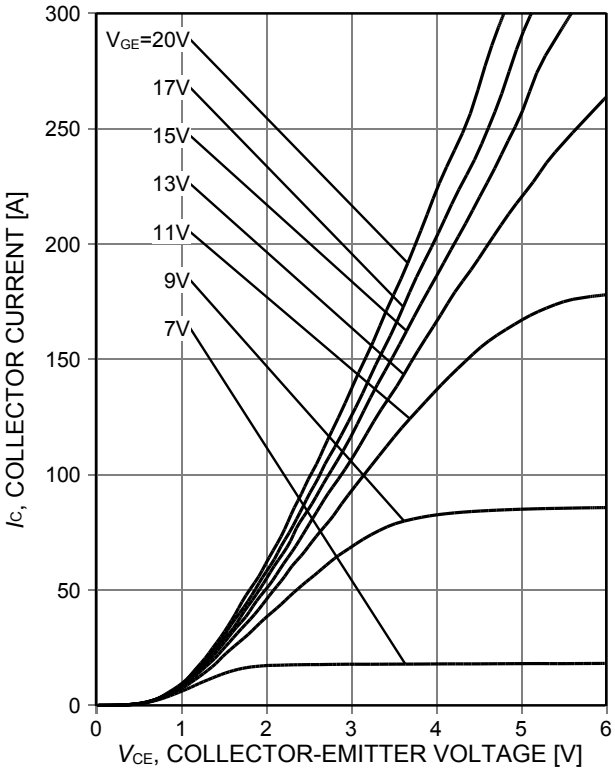

Figure 3. **Typical output characteristic** (T_{vj}=175°C)

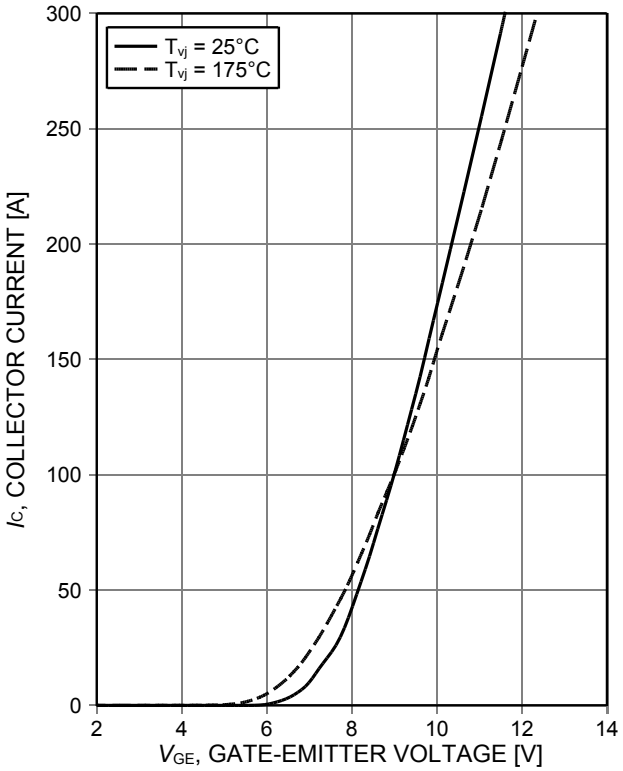

Figure 4. **Typical transfer characteristic** (V_{CE}=20V)

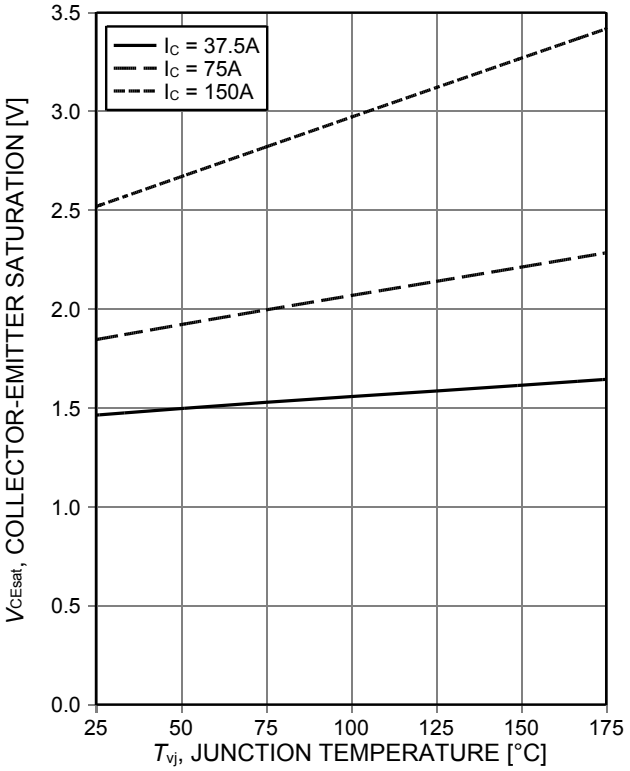

Figure 5. **Typical collector-emitter saturation voltage as a function of junction temperature** (V_{GE}=15V)

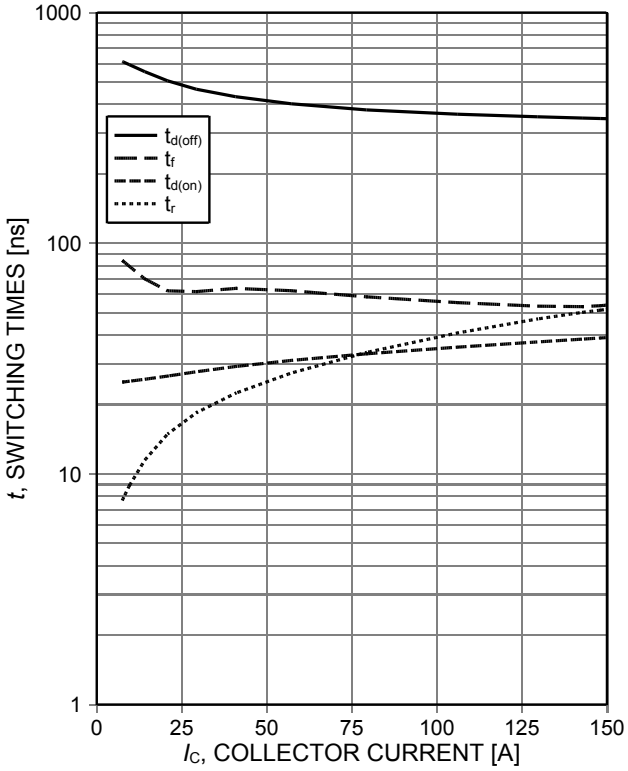

Figure 6. **Typical switching times as a function of collector current** (inductive load, T_{vj}=175°C, V_{CE}=600V, V_{GE}=0/15V, R_G=4Ω, Dynamic test circuit in Figure E)

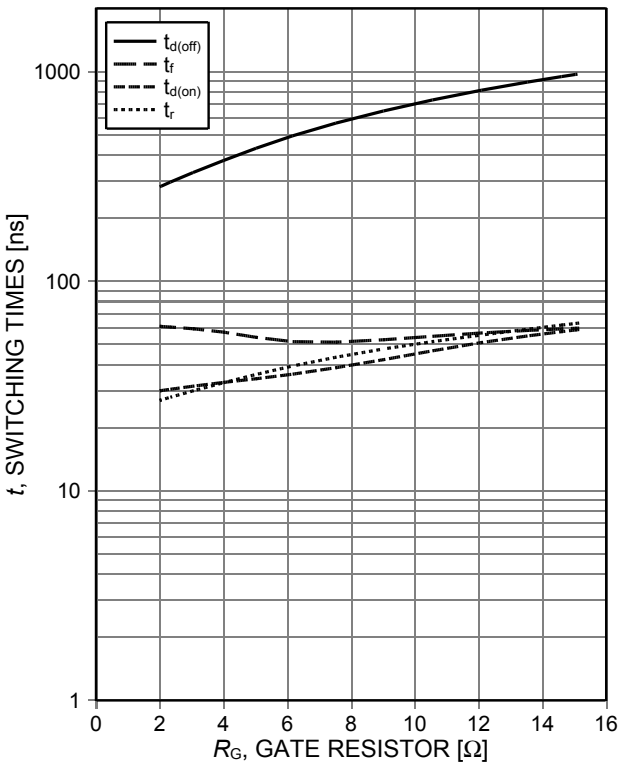

Figure 7. **Typical switching times as a function of gate resistor** (inductive load, T_{vj}=175°C, V_{CE}=600V, V_{GE}=0/15V, I_C=75A, Dynamic test circuit in Figure E)

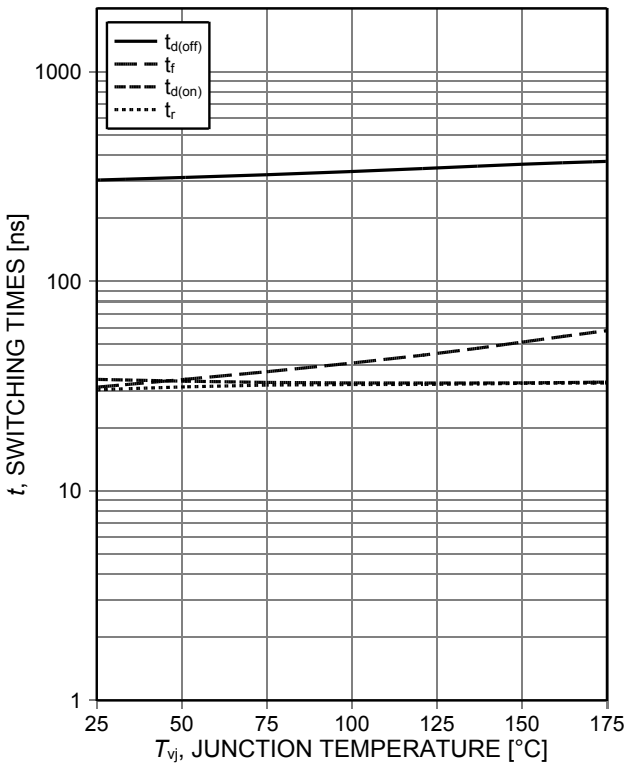

Figure 8. **Typical switching times as a function of junction temperature** (inductive load, V_{CE}=600V, V_{GE}=0/15V, I_C=75A, R_G=4Ω, Dynamic test circuit in Figure E)

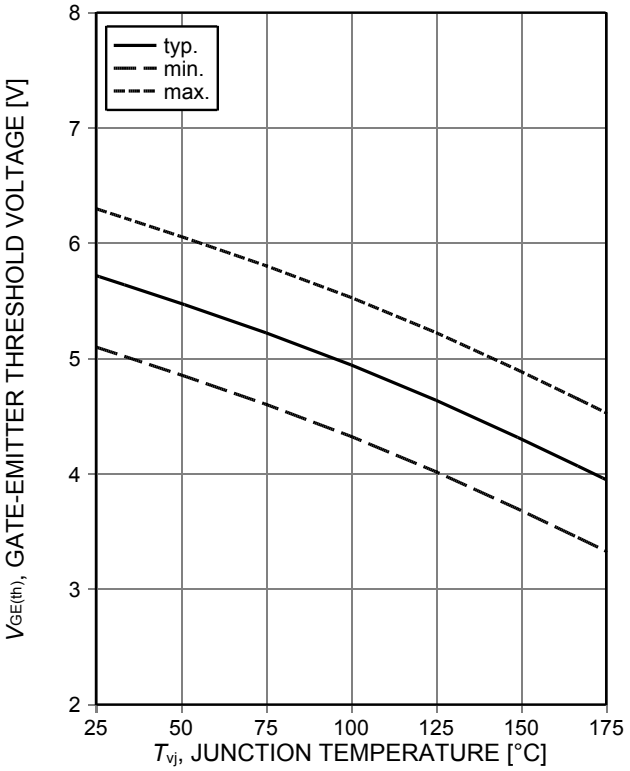

Figure 9. **Gate-emitter threshold voltage as a function of junction temperature**
(I_C=3.5mA)

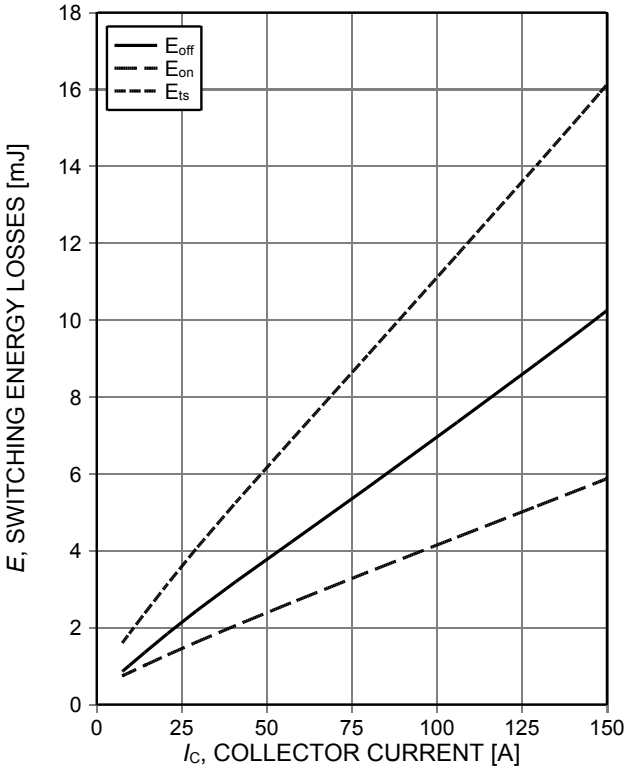

Figure 10. **Typical switching energy losses as a function of collector current**
(inductive load, T_{vj}=175°C, V_{CE}=600V, V_{GE}=0/15V, R_G=4Ω, Dynamic test circuit in Figure E)

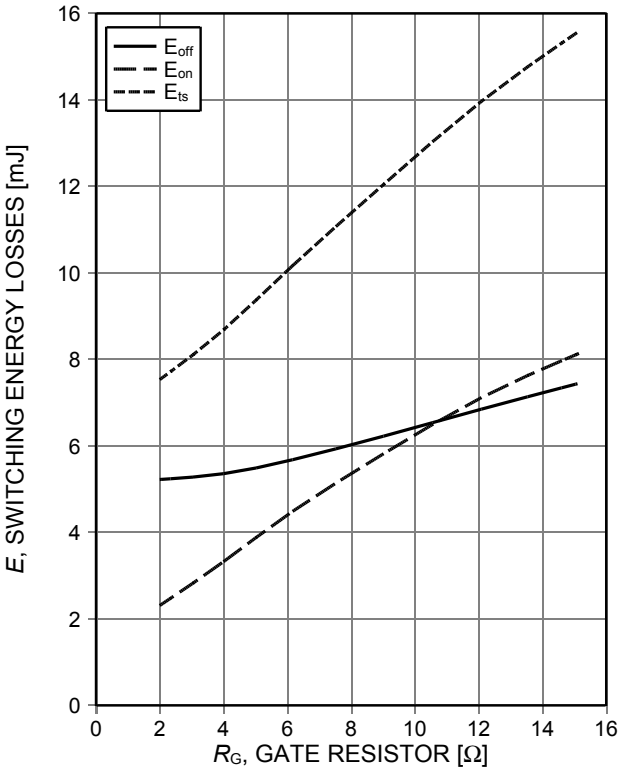

Figure 11. **Typical switching energy losses as a function of gate resistor**
(inductive load, T_{vj}=175°C, V_{CE}=600V, V_{GE}=0/15V, I_C=75A, Dynamic test circuit in Figure E)

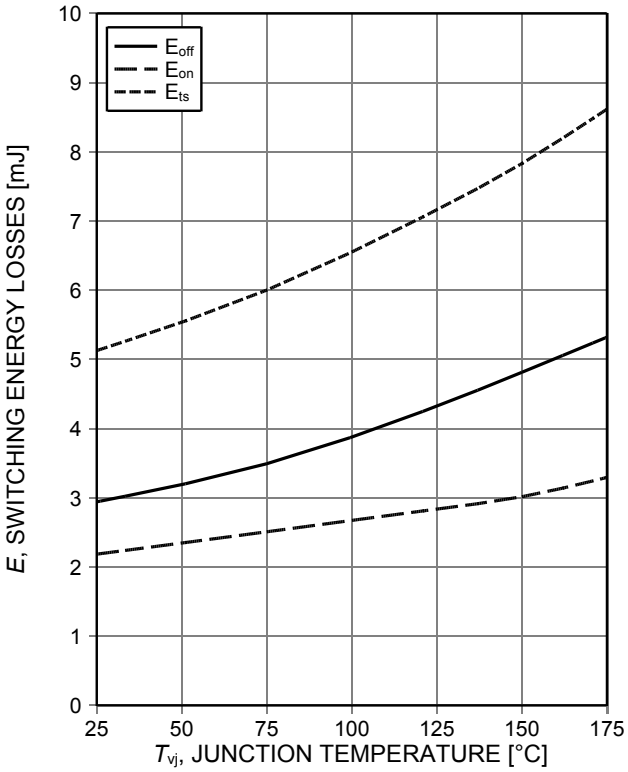

Figure 12. **Typical switching energy losses as a function of junction temperature**
(inductive load, V_{CE}=600V, V_{GE}=0/15V, I_C=75A, R_G=4Ω, Dynamic test circuit in Figure E)

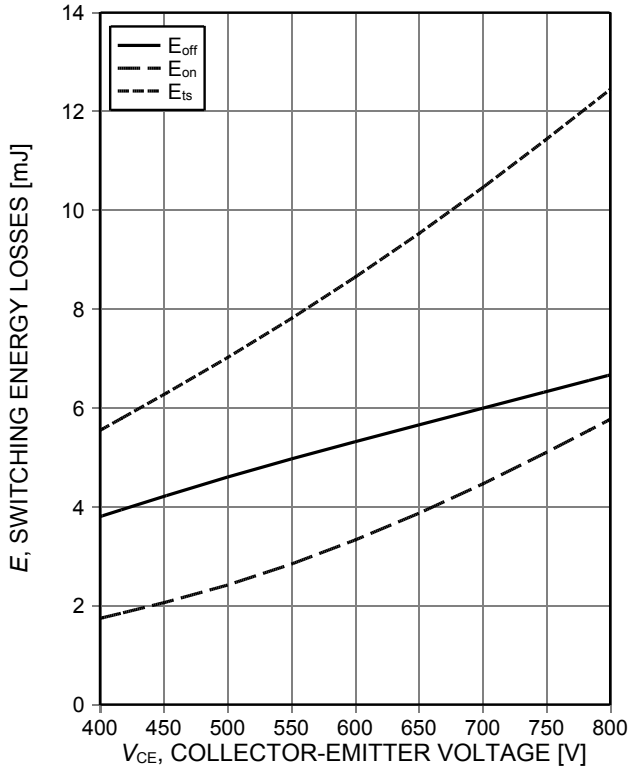

Figure 13. **Typical switching energy losses as a function of collector emitter voltage** (inductive load, T_{vj}=175°C, V_{GE}=0/15V, I_C=75A, R_G=4Ω, Dynamic test circuit in Figure E)

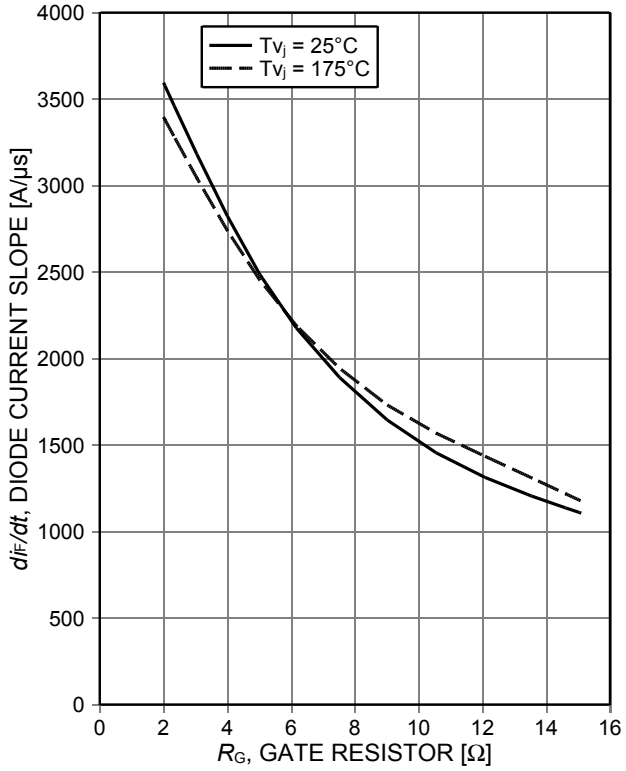

Figure 14. **Typical diode current slope as a function of gate resistor** (inductive load, V_{CE}=600V, V_{GE}=0/15V, I_C=75A, Dynamic test circuit in Figure E)

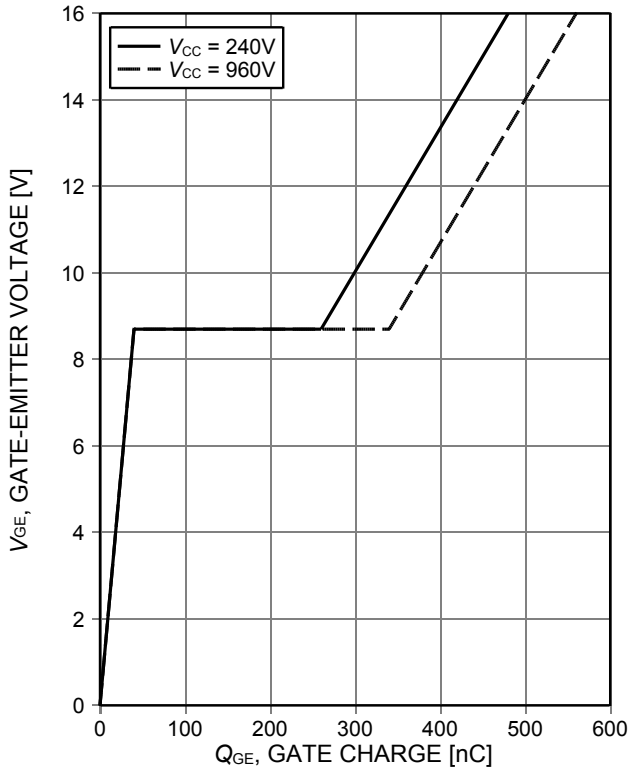

Figure 15. **Typical gate charge** (I_C=75A)

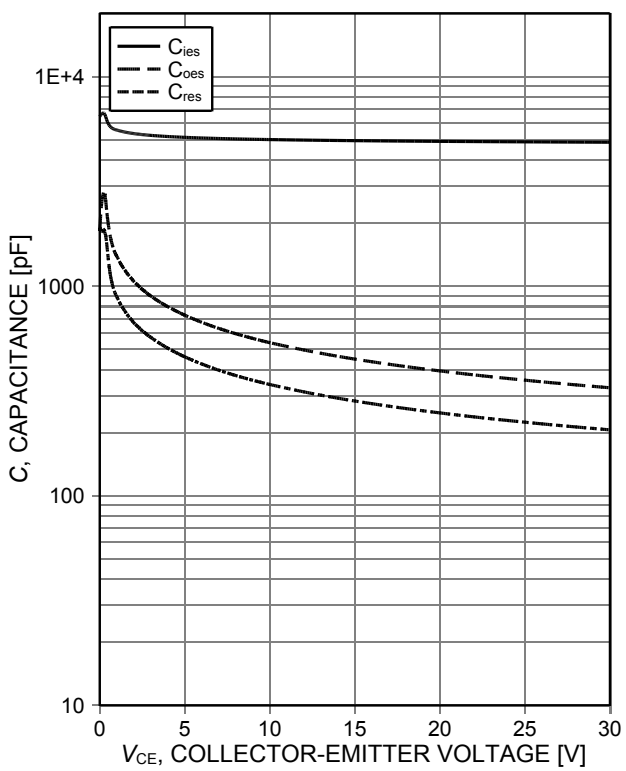

Figure 16. **Typical capacitance as a function of collector-emitter voltage** (V_{GE}=0V, f=1MHz)

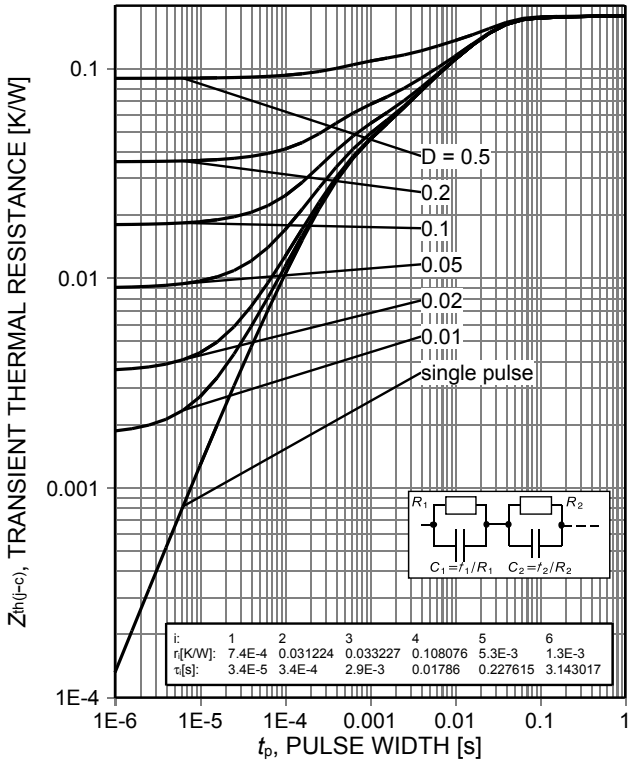

Figure 17. **IGBT transient thermal resistance** ($D=t_p/T$)

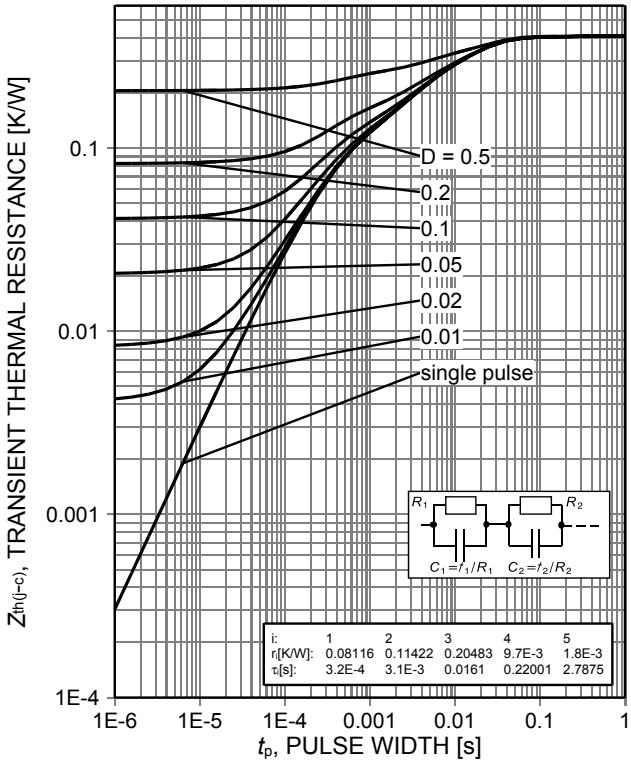

Figure 18. **Diode transient thermal impedance as a function of pulse width** ($D=t_p/T$)

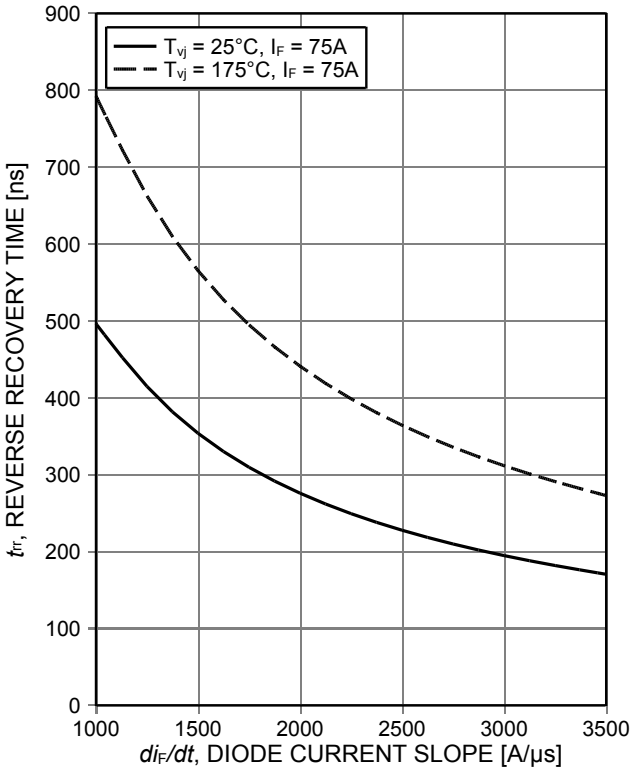

Figure 19. **Typical reverse recovery time as a function of diode current slope** (V_R=600V)

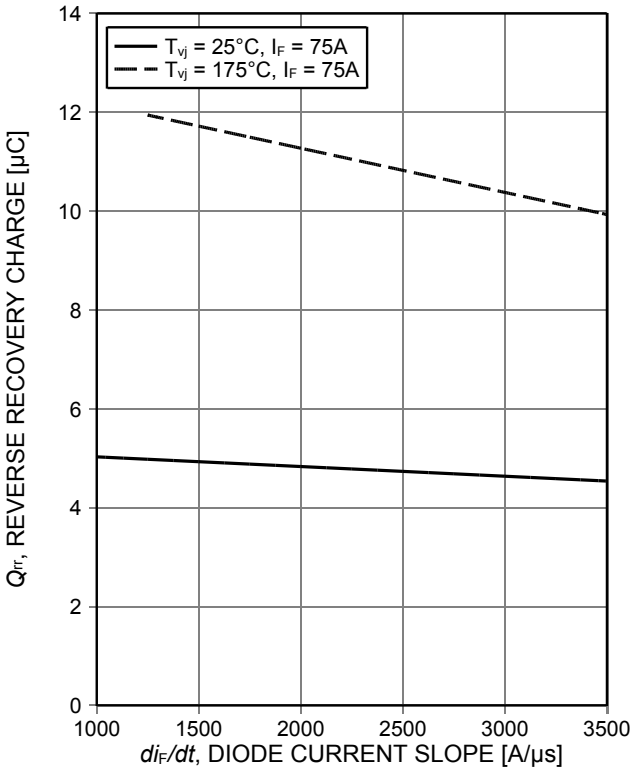

Figure 20. **Typical reverse recovery charge as a function of diode current slope** (V_R=600V)

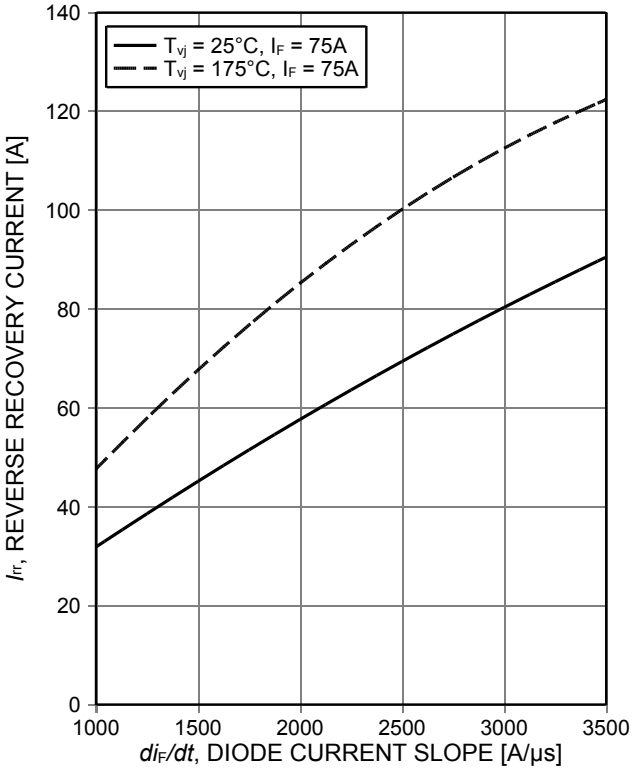

Figure 21. **Typical reverse recovery current as a function of diode current slope** (V_R=600V)

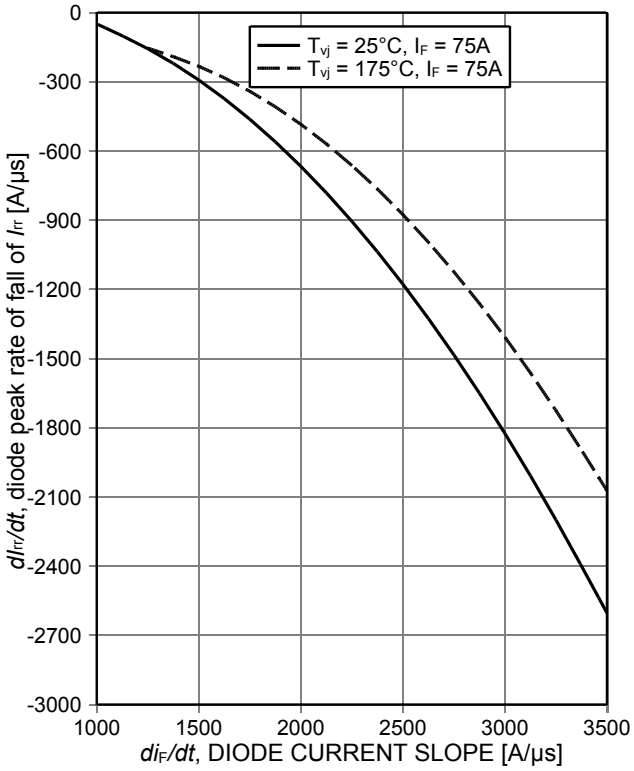

Figure 22. **Typical diode peak rate of fall of reverse recovery current as a function of diode current slope** (V_R=600V)

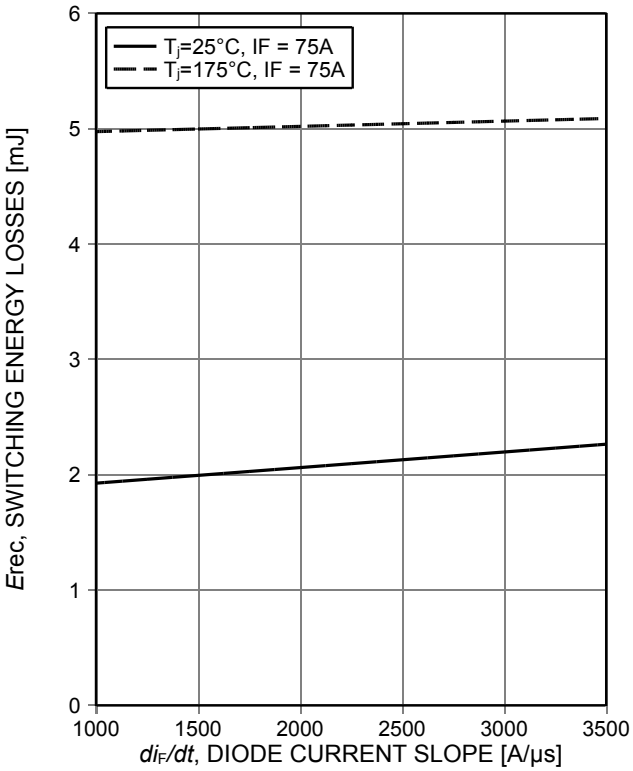

Figure 23. **Typical reverse energy losses as a function of diode current slope** (V_R=600V)

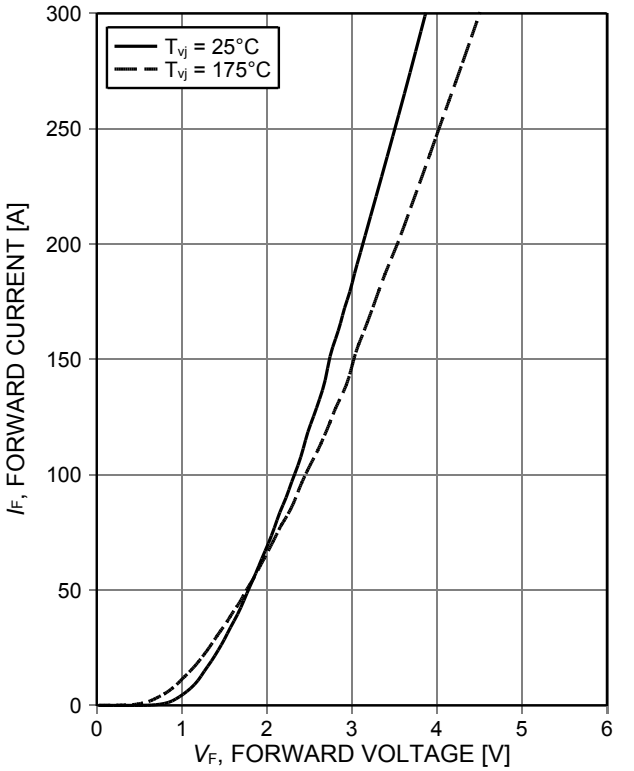

Figure 24. **Typical diode forward current as a function of forward voltage**

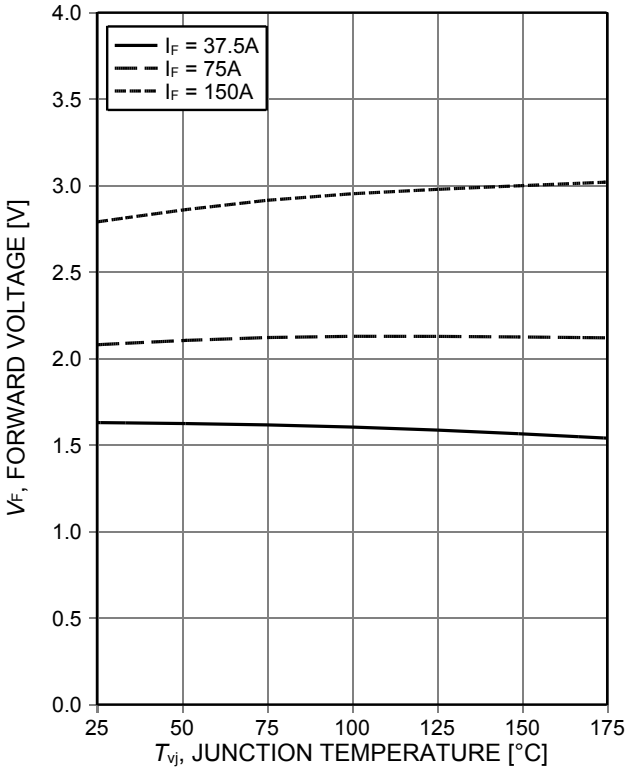

Figure 25. **Typical diode forward voltage as a function of junction temperature**

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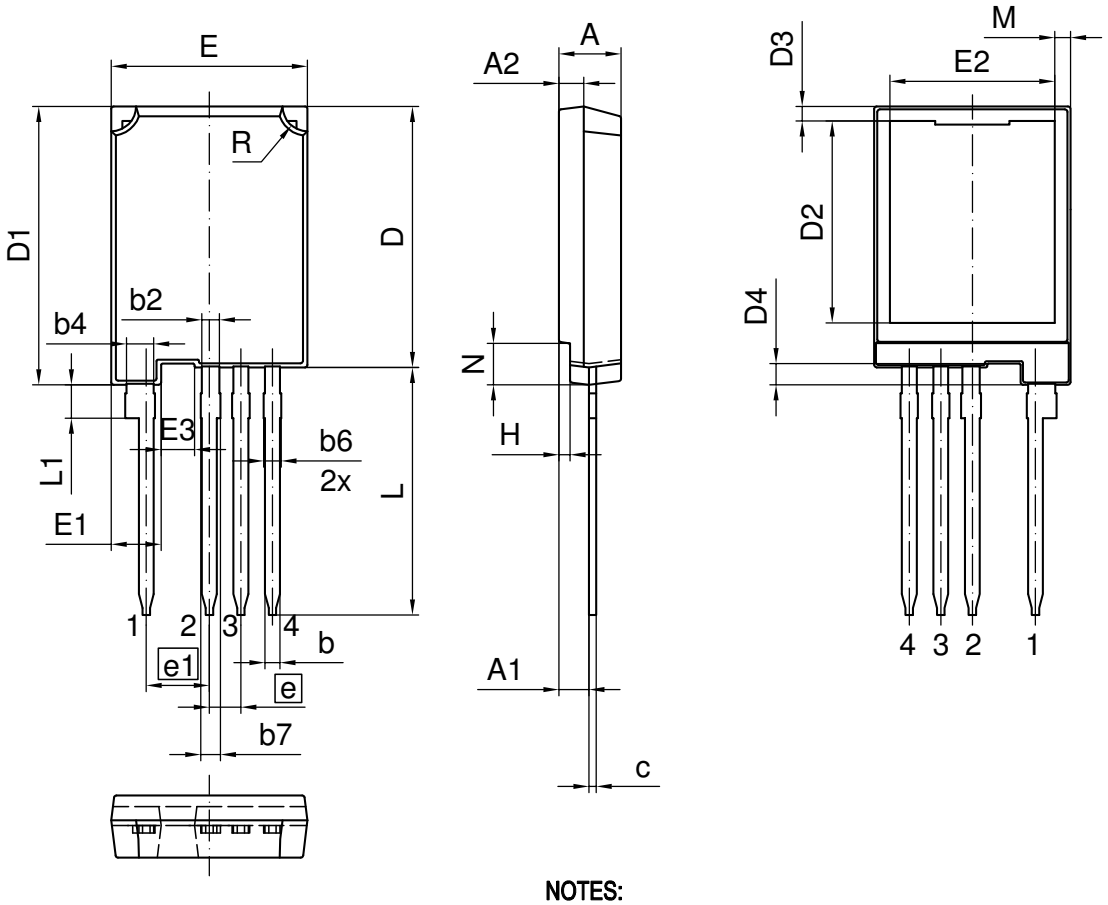

NOTES:
PACKAGE SURFACE ROUTE BETWEEN PIN 1 & PIN 2 WILL BE 5.1mm MIN.

ALL b... AND c DIMENSIONS INCLUDING PLATING EXCEPT AREA OF CUTTING

DIMENSION	MILLIMETERS	
	MIN.	MAX.
A	4.9	5.1
A1	2.31	2.51
A2	1.9	2.1
b	1.16	1.29
b2	1.36	1.49
b4	2.16	2.29
b6	1.16	1.45
b7	1.16	1.65
c	0.59	0.66
D	20.9	21.1
D1	22.3	22.5
D2	15.95	16.55
D3	1	1.35
D4	1.6	1.8
E	15.7	15.9
E1	3.9	4.1
E2	13.1	13.5
E3	2.58	2.78
e	2.54	
e1	5.08	
H	0.8	1
L	19.8	20.1
L1	2.55	2.85
M	0.97	1.57
N	3.24	3.44
R	1.9	2.1

DOCUMENT NO. Z8B00182798
REVISION 01
SCALE 2:1 0 5 10mm
EUROPEAN PROJECTION
ISSUE DATE 23.09.2016

Testing Conditions

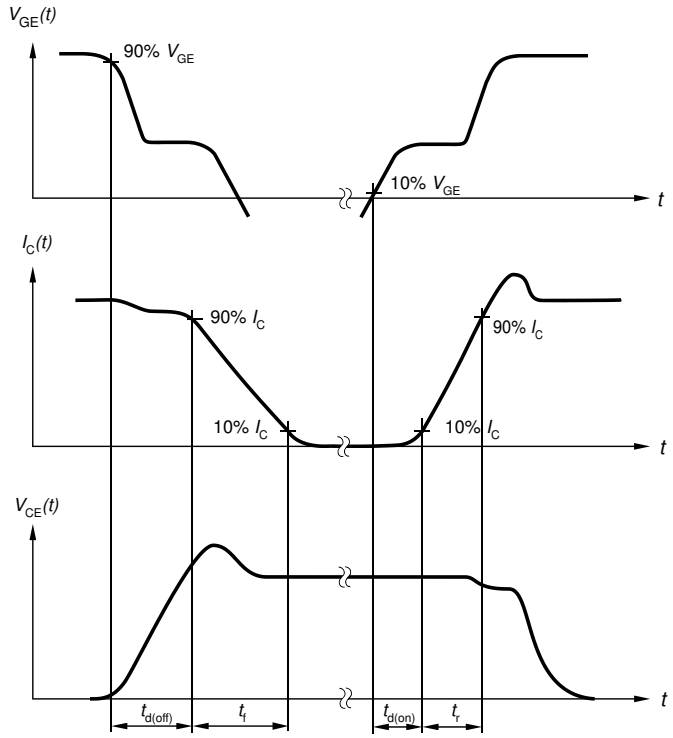

Figure A. **Definition of switching times**

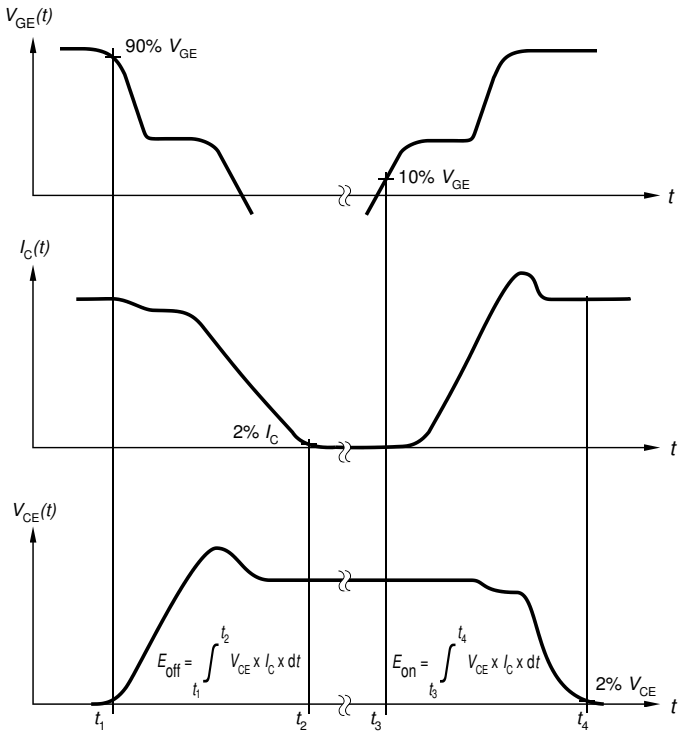

Figure B. **Definition of switching losses**

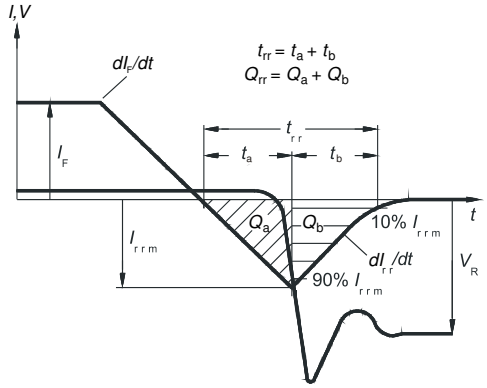

Figure C. **Definition of diode switching characteristics**

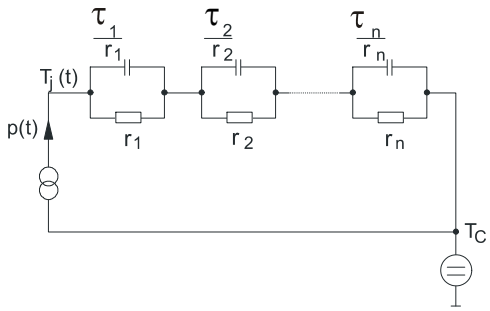

Figure D. **Thermal equivalent circuit**

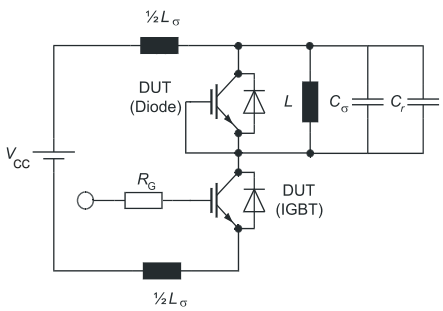

Figure E. **Dynamic test circuit**
Parasitic inductance L_σ,
parasitic capacitor C_σ,
relief capacitor C_r,
(only for ZVT switching)

Revision History

IKY75N120CS6

Revision: 2018-08-07, Rev. 2.2

Previous Revision

Revision	Date	Subjects (major changes since last revision)
2.1	2018-05-07	Final data sheet
2.2	2018-08-07	Fig.5 and Fig.25 legend correction

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